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APPLICANTS

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** CONTINUING DATA *****

This application is a CON of PCT/FR02/02341 07/04/2002

** FOREIGN APPLICATIONS *****

FRANCE 0108859 07/04/2001

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

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Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no	STATE OR	SHEETS	TOTAL	INDEPENDENT
35 USC 119 (a-d) conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance	COUNTRY	DRAWING	CLAIMS	CLAIMS
Verified and Acknowledged	FRANCE	1	20	2
Examiner's Signature: <i>Xiang</i> Initials: <i>PD</i>				

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TITLE

Method for reducing free surface roughness of a semiconductor wafer

FILING FEE	RECEIVED	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees
			<input type="checkbox"/> 1.16 Fees (Filing)
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